

FEATURES

- Precision fixed operating frequency (100kHz)
- Pulse by pulse over current limiting
- Over Current Protection
- Over Voltage Protection(min. 23V)
- Internal thermal shutdown function
- Under voltage lockout
- Internal high voltage sense FET
- Auto restart

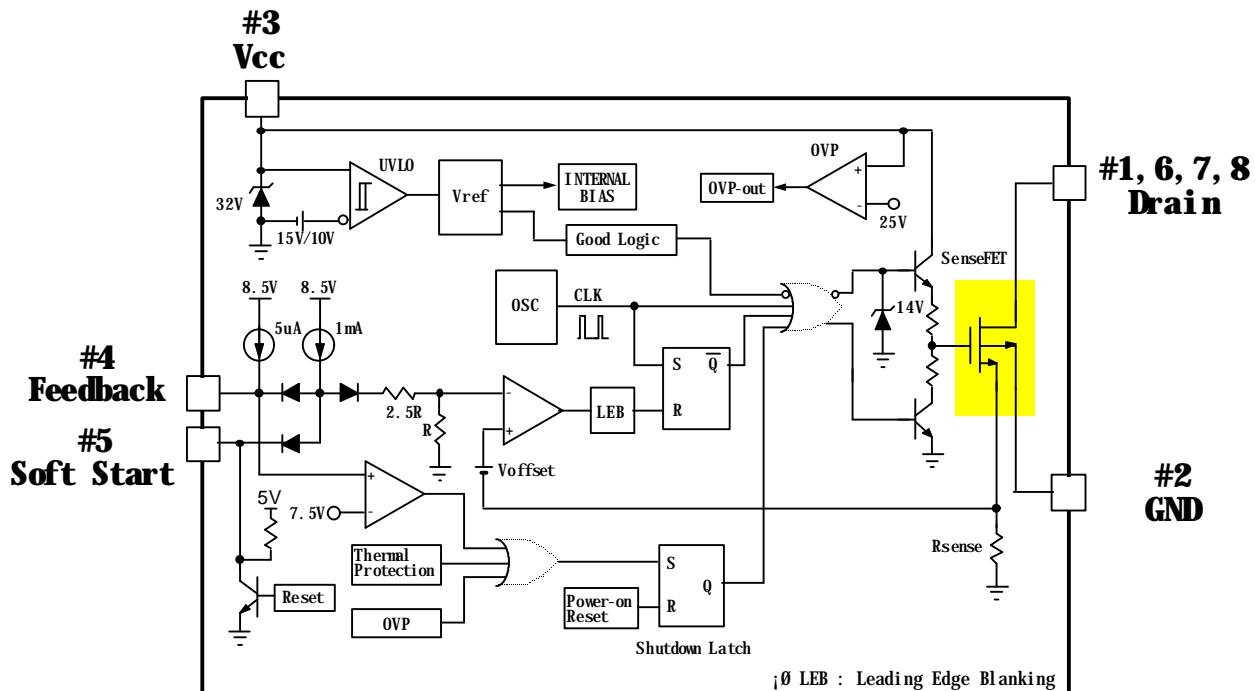
PRODUCT SUMMARY

Part Number	BVdss	Rds(on)	ID
KA1H0165R	650V	10 Ω	1A

8DIP



1,6,7,8. DRAIN 2. GND 3.Vcc 4.FB 5.S/S

BLOCK DIAGRAM

ABSOLUTE MAXIMUM RATINGS

Characteristic	Symbol	Value	Unit
Drain - Source(GND) Voltage (1)	V _{DSS}	650	V
Drain - Gate Voltage ($R_G = 1M\Omega$)	V _{DGR}	650	V
Gate - Source(GND) Voltage	V _{GS}	± 30	V
Drain Current Pulsed (2)	I _{DM}	4.0	ADC
Single Pulsed Avalanche Energy (3)	E _A	95	mJ
Avalanche Current	I _{AS}	1.0	A
Continuous Drain Current ($T_c = 25^\circ C$)	I _D	1.0	ADC
Continuous Drain Current ($T_c = 100^\circ C$)	I _D	0.7	ADC
Supply Voltage	V _{CC}	30	V
Analog Input Voltage Range	V _{FB}	-0.3 ~ V _{SD}	V
Total Power Dissipation	P _D (wt H/S)	40	W
	Derating	0.32	W/ $^\circ C$
Operating Temperature	T _{OPR}	- 25 ~ + 85	$^\circ C$
Storage Temperature	T _{TSG}	- 55 ~ + 150	$^\circ C$

Notes: (1) $T_j = 25^\circ C$ to $150^\circ C$

(2) Repetitive rating : Pulse width limited by maximum junction temperature

(3) $L = 80mH$, $V_{DD} = 50V$, $R_G = 27\Omega$, starting $T_j = 25^\circ C$

ELECTRICAL CHARACTERISTICS (SFET part)

($T_a = 25^\circ C$ unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
BV _{DSS}	Drain-Source Breakdown Voltage	650	-	-	V	$V_{GS}=0V$, $I_D=50\mu A$
I _{DSS}	Zero Gate Voltage Drain Current	-	-	50	uA	$V_{DS}=\text{Max, Rating}$, $V_{GS}=0V$
		-	-	200	uA	$V_{DS}=0.8\text{Max, Rating}$, $V_{GS}=0V$ $T_C=125^\circ C$
R _{D(on)}	Static Drain-Source On Resistance(4)	-	8	10	Ω	$V_{GS} = 10V$, $I_D = 0.5A$

ELECTRICAL CHARACTERISTICS (SFET part continued)

(Ta = 25°C unless otherwise specified)

Symbol	Characteristic	Min	Typ	Max	Units	Test Conditions
g_{fs}	Forward Transconductance(4)	0.5	-	-	mho	$V_{GS} = 0V, V_{DS} = 25V, f = 1MHz$
C_{iss}	Input Capacitance	-	250	-	pF	
C_{oss}	Output Capacitance	-	25	-	pF	
C_{rss}	Reverse Transfer Capacitance	-	10	-	pF	
$t_{d(on)}$	Turn On Delay Time	-	12	-	nS	$V_{DD} = 0.5BV_{DSS}, ID = 1.0A$ (MOSFET switching time are essentiaaly independent of operating temperature)
t_r	Rise Time	-	4	-		
$t_{d(off)}$	Turn Off Delay Time	-	30	-		
t_f	Fall Time	-	10	-		
Q_g	Total Gate Charge (Gate-Source + Gate-Drain)	-	-	21	nC	$V_{GS} = 10V, ID = 1.0A$ $V_{DS} = 0.5BV_{DSS}$ (MOSFET switching time are essentiaaly independent of operating temperature)
Q_{gs}	Gate-Source Charge	-	3	-		
Q_{gd}	Gate-Drain(Miller) Charge	-	9	-		

Notes: (1) $T_J = 25^\circ C$ to $150^\circ C$

(2) Repetitive rating : Pulse width limited by maximum junction temperature

(3) $L = 80mH, V_{DD} = 50V, R_G = 27\Omega$, starting $T_j = 25^\circ C$ (4) Pulse Test : Pulse width $\leq 300\mu S$, Duty Cycle $\leq 2\%$

ELECTRICAL CHARACTERISTICS (Control part)

(Ta = 25°C unless otherwise specified)

Symbol	Characteristics	Min	Typ	Max	Unit	Test Conditions
REFERENCE SECTION						
Vref	Output Voltage (Note 1)	4.80	5.00	5.20	V	Ta = 25°C
Vref/ΔT	Temperature Stability (Note 1&2)	-	0.3	0.6	mV/°C	-25°C ≤ Ta ≤ +85°C
OSCILLATOR SECTION						
Fosc	Initial Accuracy	90	100	110	KHz	Ta = 25°C
ΔF/ΔT	Frequency Change with Temperature (Note 2)	-	± 5	± 10	%	-25°C ≤ Ta ≤ +85°C
PWM SECTION						
D _{MAX}	Maximum Duty Cycle	64	67	70	%	
FEEDBACK SECTION						
I _{FB}	Feedback Source Current	0.7	0.9	1.1	mA	Ta = 25°C , 0 V ≤ V _{fb} ≤ 3V
I _{delay}	Shutdown Delay Current	4.0	5.0	6.0	uA	Ta = 25°C , 5 V ≤ V _{fb} ≤ V _{SD}
OVER CURRENT PROTECTION SECTION						
I _{L(MAX)}	Over Current Protection	0.53	0.6	0.67	A	Max. Inductor Current
UVLO SECTION						
V _{th(H)}	Start Threshold Voltage	14	15	16	V	
V _{th(L)}	Minimum Operating Voltage	9	10	11	V	After turn on

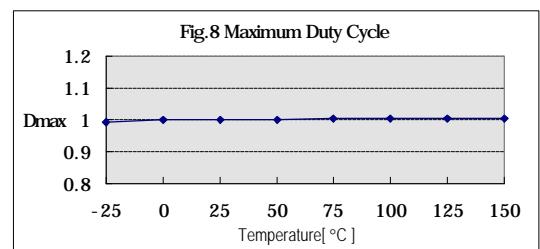
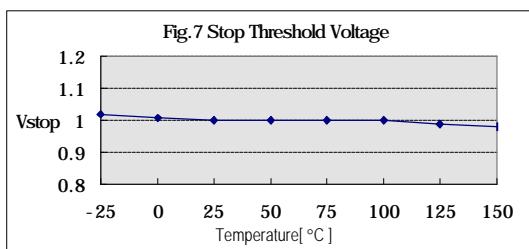
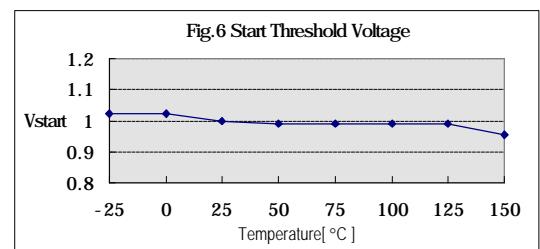
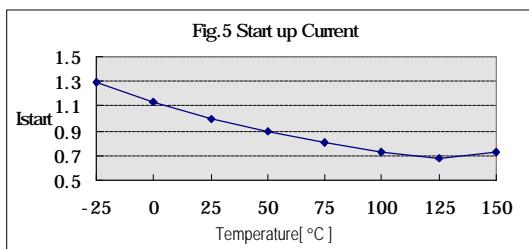
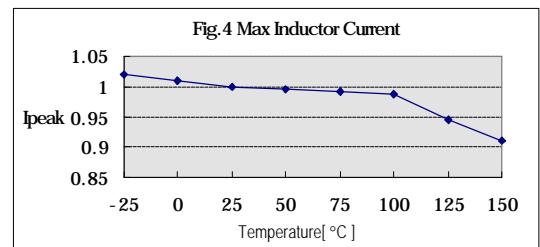
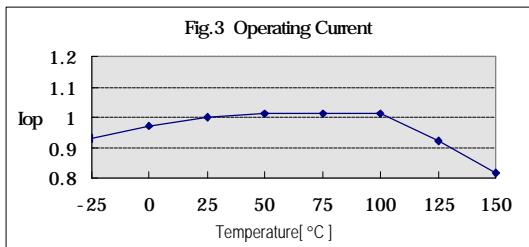
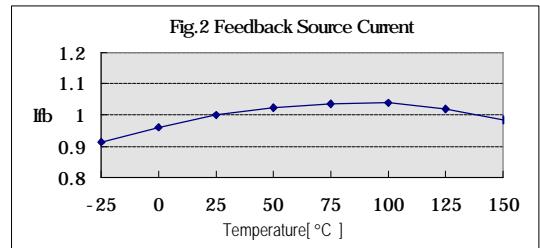
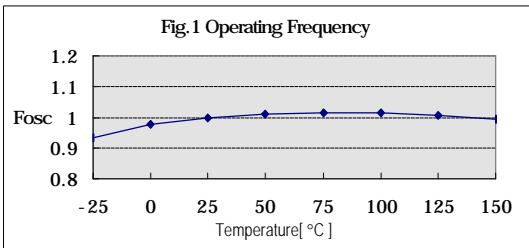
ELECTRICAL CHARACTERISTICS (Continued)

(Ta = 25°C unless otherwise specified)

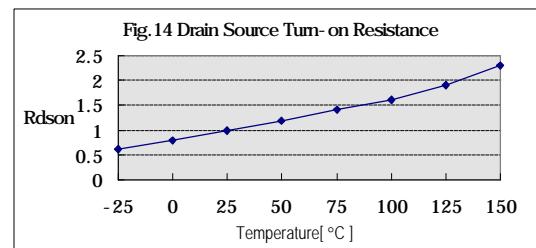
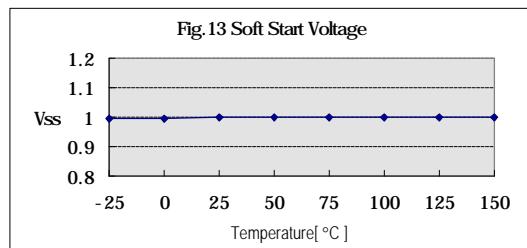
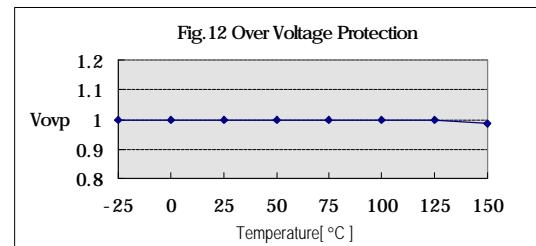
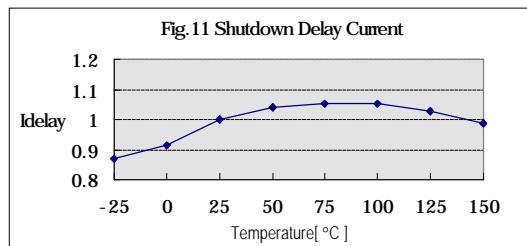
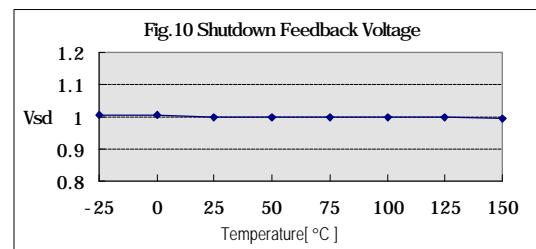
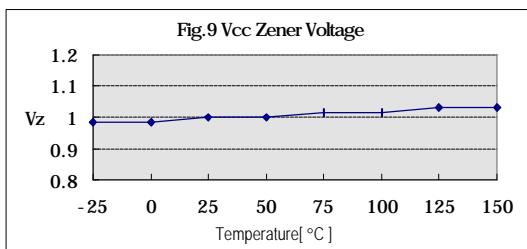
Symbol	Characteristics	Min	Typ	Max	Unit	Test Conditions
TOTAL STANDBY CURRENT SECTION						
IST	Start up Current	0.1	0.3	0.45	mA	VCC = 14V
IOPR	Operating Supply Current (control part only)	6	12	18	mA	Ta = 25°C
VZ	Vcc Zener Voltage	30	32.5	35	V	ICC = 20mA
SHUTDOWN SECTION						
VSD	Shutdown Feedback Voltage	6.9	7.5	8.1	V	
T SD	Thermal Shutdown Temperature(Tj)	140	160	-	°C	(Note 1)
Vovp	Over Voltage Protection Voltage	23	25	28	V	

Notes: (1) These parameters, although guaranteed, are not 100% tested in production
(2) These parameters, although guaranteed, are tested in EDS(wafer test) process

TYPICAL PERFORMANCE CHARACTERISTICS

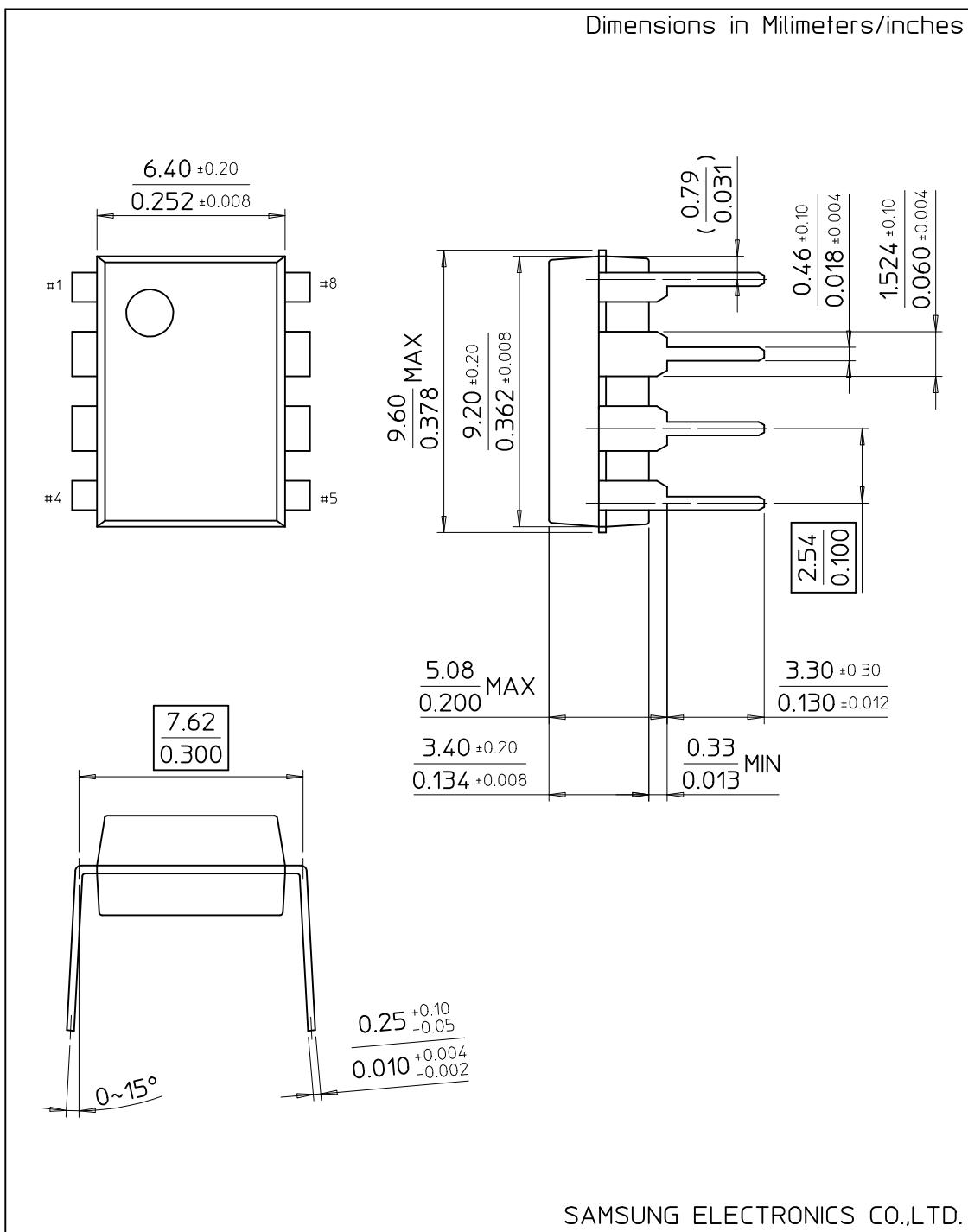


TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



8-DIP-300

Dimensions in Millimeters/inches



SAMSUNG ELECTRONICS CO.,LTD.